Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/751,762	KOTTAPALLI ET AL.	
Examiner	Art Unit	
Daniel Pan	2183	

SEARCHED						
Class	Subclass	Date	Examiner			
712	227 245	3/8/2007	DP			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NO)
	DATE	EXMR
pgp uspat jpoabs epoabs derwent IBM TD IEEE NPL		
718/104 714/16 717/120 713/401 delay cycle	3/8/2007	DP
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